FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

#### INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use several sheets if necessary)

(37 CFR 1.98(b)

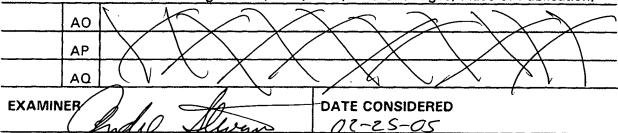
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# FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

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Form Y&T (3/94)

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<sup>\*</sup> Abstract provided for the Examiner's convenience

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FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

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APPLICANT Hiroaki TANAKA et al	• .

FILING DATE May 31, GROUP 2971 2001

### **U.S. PATENT DOCUMENTS**

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#### FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

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Form Y&T (3/94)

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PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

# INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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APPLICANT

Hiroaki TANAKA et al.

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## U.S. PATENT DOCUMENTS **EXAMINER** ISSUE SUB INITIAL FILING DATE PATENT NUMBER DATE PATENTEE ) CLASS **CLASS** IF APPROPRIATE AA AB AC AD ΑE AF AG AH FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION PUBL. TRANSLATION YES NO DOCUMENT NO. DATE COUNTRY OR PATENT OFFICE CLASS CLASS 4-253028 AJ 09-92 Japan No AK AL AM AN OTHER DOCUMENTS (Including Author, Title, Date, Relevant Pages, Place of Publication) AO AP AQ **EXAMINER DATE CONSIDERED** 02-25-05

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